

20V P-Channel Enhancement Mode MOSFET

VDS= -20V

RDS(ON), Vgs@-4.5V, Ids@-2.8A < 130mΩ

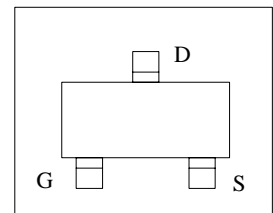
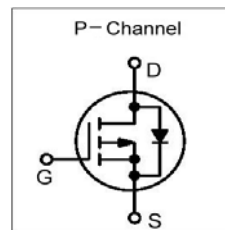
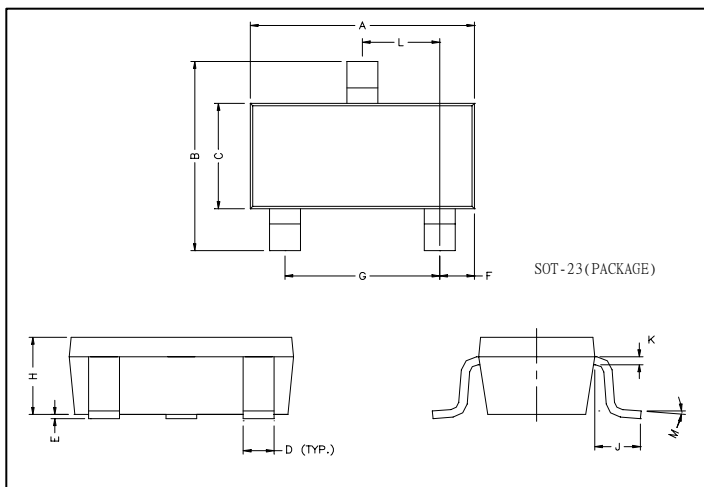
RDS(ON), Vgs@-2.5V, Ids@-2.0A < 190mΩ

Features

Advanced trench process technology

High Density Cell Design For Ultra Low On-Resistance

Package Dimensions



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	1.90	REF.
B	2.40	2.80	H	1.00	1.30
C	1.40	1.60	K	0.10	0.20
D	0.35	0.50	J	0.40	-
E	0	0.10	L	0.85	1.15
F	0.45	0.55	M	0°	10°

Maximum Ratings and Thermal Characteristics (TA = 25oC unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	-20	V	
Gate-Source Voltage	V _{GS}	±8		
Continuous Drain Current	I _D	-2.2	A	
Pulsed Drain Current ¹⁾	I _{DM}	-8		
Maximum Power Dissipation ²⁾	P _D	TA = 25°	1.25	W
		TA = 75°C	0.8	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C	
Junction-to-Ambient Thermal Resistance (PCB mounted) ²⁾	R _{thJA}	100	°C/W	
Junction-to-Ambient Thermal Resistance (PCB mounted) ³⁾		166		

Notes

- 1) Pulse width limited by maximum junction temperature.
- 2) Surface Mounted on FR4 Board, t ≤ 5 sec.
- 3) Surface Mounted on FR4 Board.



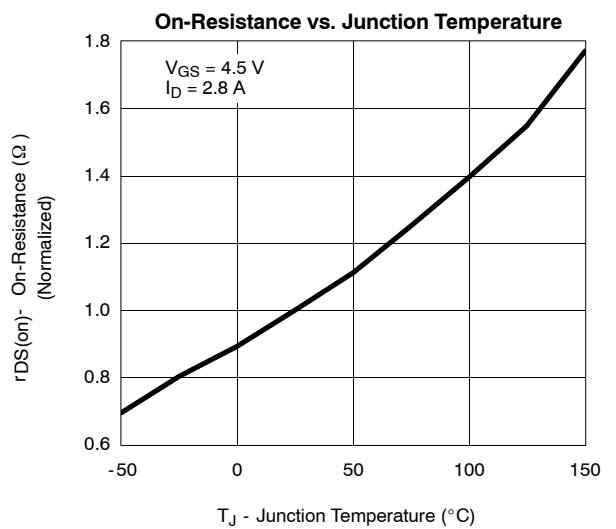
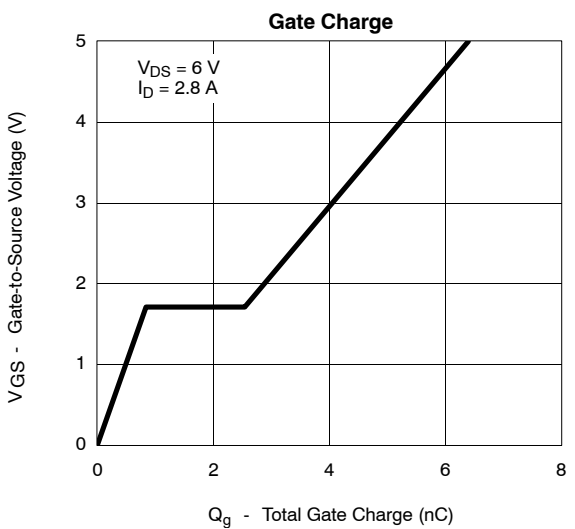
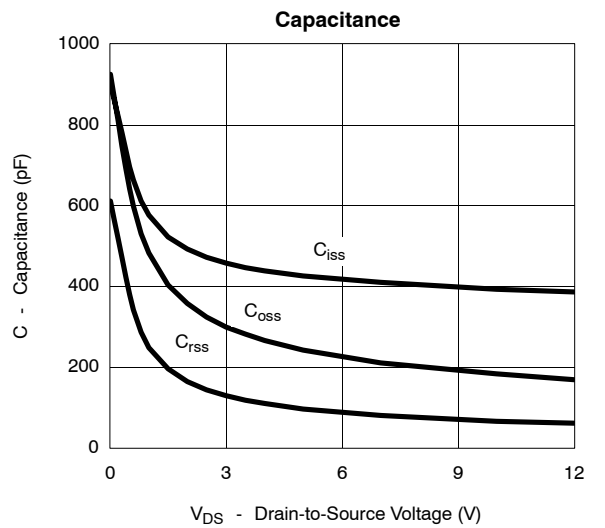
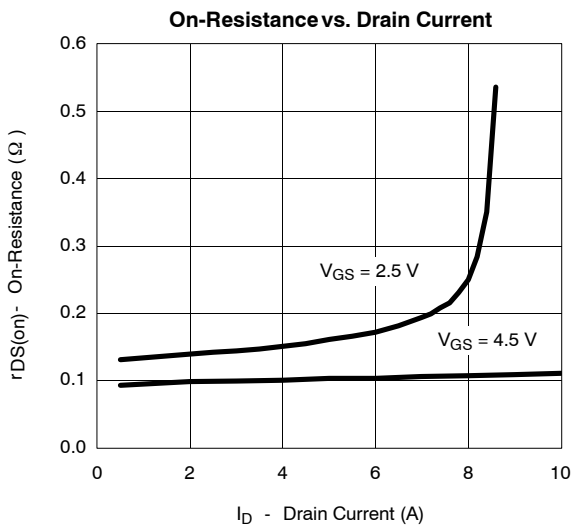
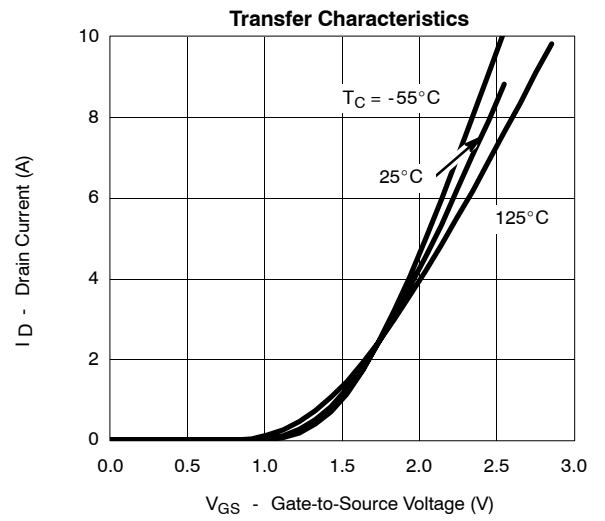
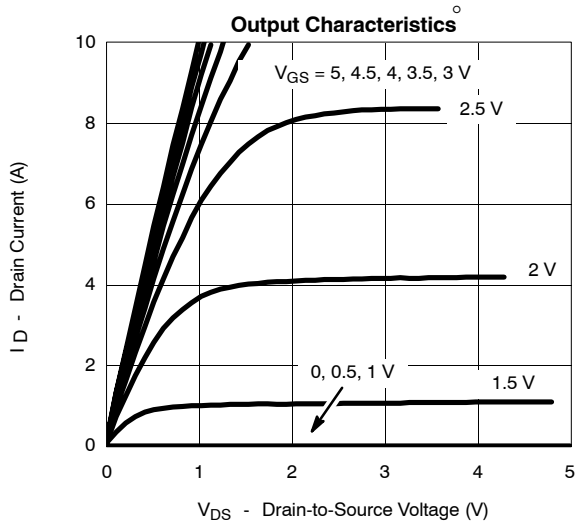
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ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-20			V
Drain-Source On-State Resistance ¹⁾	$R_{DS(on)}$	$V_{GS} = -4.5V, I_D = -2.8A$		105	130	mΩ
		$V_{GS} = -2.5V, I_D = -2.0A$		145	190	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.45			V
Zero Gate Voltage Drain Current I_{D0}	I_{DSS}	$V_{DS} = -20V, V_{GS} = 0V$			-1	uA
		$V_{DS} = -20V, V_{GS} = 0V, T_J = 55^\circ C$			-10	
Gate Body Leakage	I_{GSS}	$V_{GS} = \pm 8V, V_{DS} = 0V$			±100	nA
Forward Transconductance ¹⁾	g_{fs}	$V_{DS} = -5V, I_D = -2.8A$		6.5	—	S
Dynamic						
Total Gate Charge	Q_g	$V_{DS} = -6V, I_D \cong -2.8A$ $V_{GS} = -4.5V$		5.8	10	nC
Gate-Source Charge	Q_{gs}			0.85		
Gate-Drain Charge	Q_{gd}			1.7		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -6V, R_L = 6\Omega$ $I_D \cong -1.0A, V_{GEN} = -4.5V$ $R_G = 6\Omega$		13	25	ns
Turn-On Rise Time	t_r			36	60	
Turn-Off Delay Time	$t_{d(off)}$			42	70	
Turn-Off Fall Time	t_f			34	60	
Input Capacitance	C_{iss}	$V_{DS} = -6V, V_{GS} = 0V$ $f = 1.0 MHz$		415		pF
Output Capacitance	C_{oss}			223		
Reverse Transfer Capacitance	C_{rss}			87		
Source-Drain Diode						
Max. Diode Forward Current	I_S				-1.6	A
Diode Forward Voltage	V_{SD}	$I_S = -1.6A, V_{GS} = 0V$		-0.8	-1.2	V

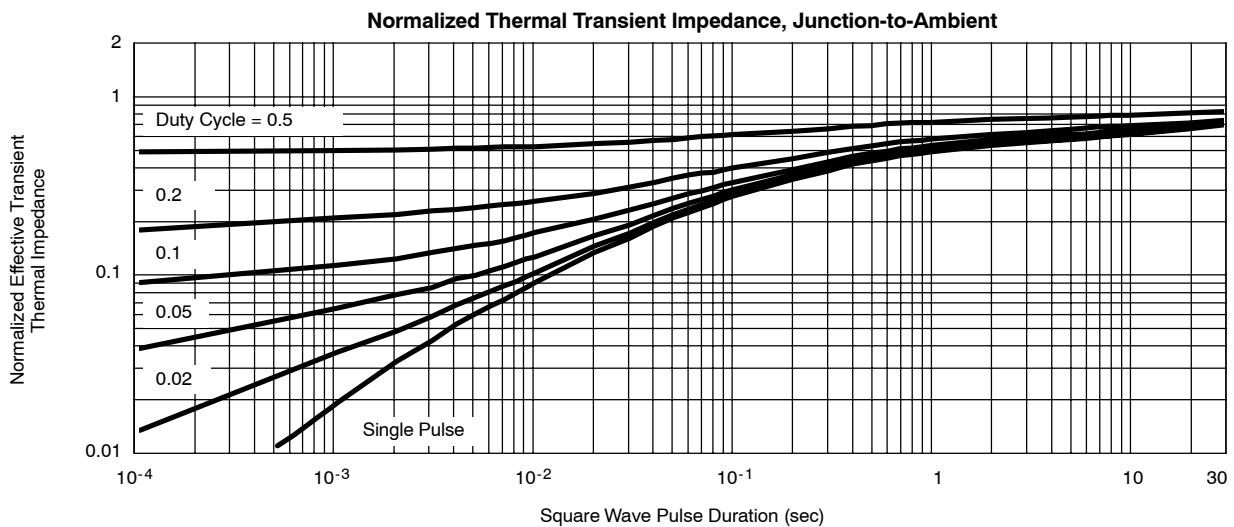
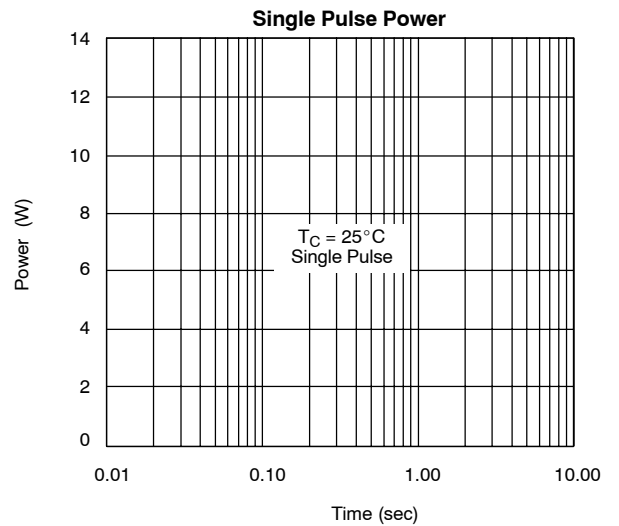
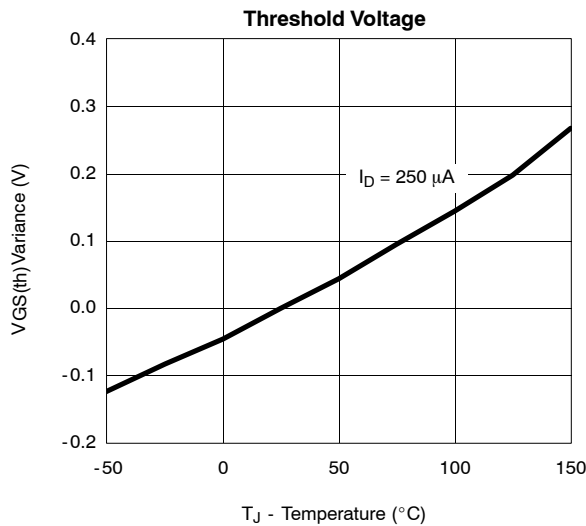
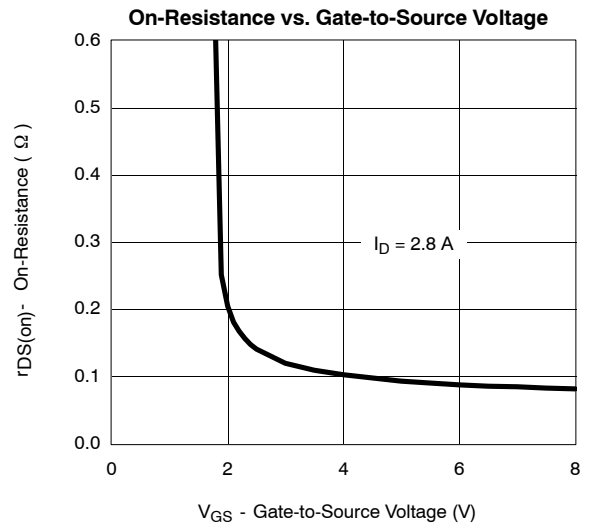
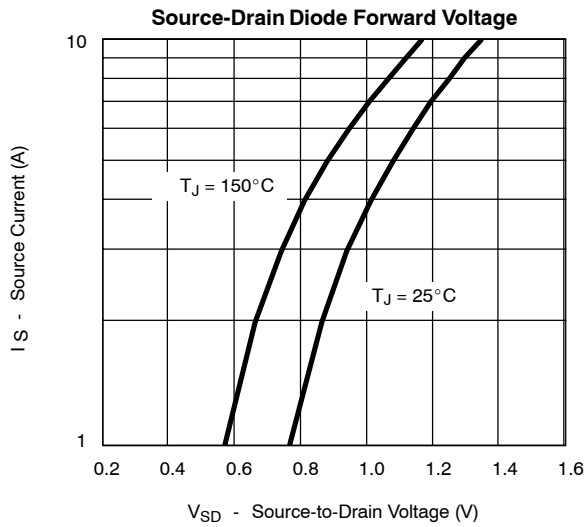
¹⁾ Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%

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